

<b>Notice of References Cited</b>	Application/Control No. 10/539,799		Applicant(s)/Patent Under Reexamination PECHSTEIN ET AL.	
	Examiner Dean Kwak		Art Unit 1797	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,340,894	01-2002	Farnworth et al.	324/755
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	K	US-			
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**NON-PATENT DOCUMENTS**

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